

Search Notes

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10/523,524

Examiner

EDMUND H. LEE

Applicant(s)/Patent under
Reexamination

SEITOH ET AL.

Art Unit

1791

SEARCHED

Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED

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**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
updated	6/18/2009	EHL
264/275,328.12,328.9,294		